

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANTS : Hideyasu TAKATO
SERIAL NO. : (Unassigned)
FILED : (Herewith)
FOR : FOCUS DETECTING SYSTEM AND CAMERA PROVIDED WITH THE SAME
GROUP ART UNIT : (Unassigned)
Examiner : (Unassigned)

COMMISSIONER FOR PATENTS
P.O. Box 1450
Alexandria, Virginia 22313-1450

**INFORMATION DISCLOSURE STATEMENT
UNDER 37 C.F.R. § 1.97 & § 1.98**

SIR:

In conformance with Applicant's duty of disclosure under 37 C.F.R. § 1.56 and § 1.97(b)(1), the references listed on the attached form PTO-1449 are hereby brought to the Examiner's attention.

In accordance with the requirements of 37 C.F.R. § 1.98, copies of the references are submitted herewith.

It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear in the "references cited" on any patent to issue therefrom.

Respectfully submitted,



John C. Altmiller
(Reg. No. 25,951)

Dated: 08 December 2003

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FORM PTO-1449**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT(S)**

Atty Docket No. : 12577/25
 Serial No. :
 Inventors : H. TAKATO
 Filed : (Herewith)
 Group Art Unit :
 Examiner :

U.S. PATENT DOCUMENTS

<u>Examiner Initial</u>	<u>Patent Number</u>	<u>Patent Date</u>	<u>Name</u>	<u>Class/Subclass</u>	<u>Filing Date</u>
_____	4,699,493	10/13/87	KOYAMA et al.	354/406	
_____	4,716,431	12/29/87	SHINDO	354/407	
_____	4,849,782	07/18/89	KOYAMA et al.	354/408	

FOREIGN PATENT DOCUMENTS

<u>Examiner Initial</u>	<u>Document Number</u>	<u>Date</u>	<u>Country</u>	<u>Class/Subclass</u>	<u>Translation Yes</u> <u>No</u>
_____	62-032013	02/12/87	Japan		ABS.
_____	60-032012	02/19/85	Japan		ABS.

OTHER DOCUMENTS

(Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner Initial

EXAMINER**DATE CONSIDERED**

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.